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CONTENTS

	PAGE
BÜHLMANN, P., KALISCH, M. and MAATHUIS, M. H. Variable selection in high-dimensional linear models: partially faithful distributions and the PC-simple algorithm	261
DONG, Y. and LI, B. Dimension reduction for non-elliptically distributed predictors: second-order methods	279
ZHU, L., WANG, T., ZHU, L. and FERRÉ, L. Sufficient dimension reduction through discretization-expectation estimation	295
HU, Z., FOLLMANN, D. A. and QIN, J. Semiparametric dimension reduction estimation for mean response with missing data	305
LIN, D. Y. and ZENG, D. On the relative efficiency of using summary statistics versus individual-level data in meta-analysis	321
ROSENBAUM, P. R. Evidence factors in observational studies	333
SHAO, J., YU, X. and ZHONG, B. A theory for testing hypotheses under covariate-adaptive randomization	347
LEE, A. J., SCOTT, A. J. and WILD, C. J. Efficient estimation in multi-phase case-control studies	361
GANDY, A., KVALØY, J. T., BOTTLE, A. and ZHOU, F. Risk-adjusted monitoring of time to event	375
CAI, T., TIAN, L., UNO, H., SOLOMON, S. D. and WEI, L. J. Calibrating parametric subject-specific risk estimation	389
WU, S. S., WANG, W. and YANG, M. C. K. Interval estimation for drop-the-losers designs	405
MEI, Y. Efficient scalable schemes for monitoring a large number of data streams	419
SANDERSON, J., FRYZLEWICZ, P. and JONES, M. W. Estimating linear dependence between non-stationary time series using the locally stationary wavelet model	435
FEARNHEAD, P., WYNCOLL, D. and TAWN, J. A sequential smoothing algorithm with linear computational cost	447
CARVALHO, C. M., POLSON, N. G. and SCOTT, J. G. The horseshoe estimator for sparse signals	465
SEVERINI, T. A. Likelihood ratio statistics based on an integrated likelihood	481
MISCELLANEA	
DiCICCIO, T. J. and YOUNG, G. A. Objective Bayes and conditional inference in exponential families	497
LAKHAL-CHAIEB, M. L. Copula inference under censoring	505
DETTE, H., KISS, C., BEVANDA, M. and BRETZ, F. Optimal designs for the emax, log-linear and exponential models	513

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